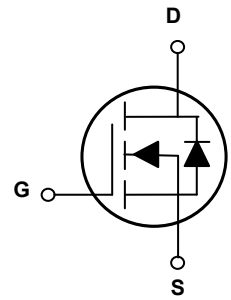


Main Product Characteristics

V_{DS}	650V
$R_{DS(ON)}$	950m Ω
I_D	4A



TO-251



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The GSGG6504 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage ($V_{GS}=0\text{V}$)	V_{DS}	650	V
Gate-Source Voltage ($V_{DS}=0\text{V}$), AC ($f>1\text{ Hz}$)	V_{GS}	± 30	V
Drain Current-Continuous ($T_C=25^\circ\text{C}$)	I_D	4	A
Drain Current-Continuous ($T_C=100^\circ\text{C}$)	I_D	2.5	A
Drain Current-Pulsed ¹	I_{DM}	16	A
Maximum Power Dissipation ($T_C=25^\circ\text{C}$)	P_D	41	W
Power Dissipation-Derate above 25°C		0.328	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy ²	E_{AS}	27	mJ
Avalanche Current ¹	I_{AR}	0.7	A
Repetitive Avalanche energy, t_{AR} limited by T_{Jmax} ¹	E_{AR}	0.1	mJ
Drain Source Voltage Slope, $V_{DS} \leq 480\text{ V}$	dv/dt	50	V/ns
Reverse Diode dv/dt , $V_{DS} \leq 480\text{ V}$, $I_{SD} < I_D$	dv/dt	15	V/ns
Operating Junction Range	T_J	-55 To +150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55 To +150	$^\circ\text{C}$
Thermal Resistance, Junction-to-Case (Maximum)	R_{thJC}	3.0	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient (Maximum)	R_{thJA}	62	$^\circ\text{C/W}$

Electrical Characteristics (T_A=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
On/Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	650	-	-	V
Zero Gate Voltage Drain Current (T _C =25°C)	I _{DSS}	V _{DS} =650V, V _{GS} =0V	-	-	1	μA
Zero Gate Voltage Drain Current (T _C =125°C)	I _{DSS}	V _{DS} =650V, V _{GS} =0V	-	-	50	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =250μA	3	-	4	V
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =2A	-	950	1100	mΩ
Dynamic and Switching Characteristics						
Input Capacitance	C _{iss}	V _{DS} =50V, F=1.0MHz V _{GS} =0V	-	304	-	pF
Output Capacitance	C _{oss}		-	18	-	pF
Reverse Transfer Capacitance	C _{rss}		-	0.6	-	pF
Total Gate Charge	Q _g	V _{DS} =480V, I _D =4A, V _{GS} =10V	-	8.8	12	nC
Gate-Source Charge	Q _{gs}		-	2.3	-	nC
Gate-Drain Charge	Q _{gd}		-	4	-	nC
Turn-on Delay Time	t _{d(on)}	V _{DD} =380V, I _D =2.5A, R _G =5Ω, V _{GS} =10V	-	8	-	nS
Turn-on Rise Time	t _r		-	4	-	nS
Turn-Off Delay Time	t _{d(off)}		-	52	70	nS
Turn-Off Fall Time	t _f		-	9	18	nS
Source-Drain Diode Characteristics and Maximum Ratings						
Source-drain Current	I _S	T _C =25°C	-	-	4	A
Pulsed Source-drain Current	I _{SDM}		-	-	16	A
Forward On Voltage	V _{SD}	T _J =25°C, I _{SD} =4A, V _{GS} =0V	-	0.9	1.2	V
Reverse Recovery Time	t _{rr}	T _J =25°C, I _F =2A, di/dt=100A/μs	-	200	-	nS
Reverse Recovery Charge	Q _{rr}		-	0.6	-	uC
Peak Reverse Recovery Current	I _{rrm}		-	6	-	A

Note:

1. Repetitive rating: Pulsed width limited by maximum junction temperature.
2. T_J=25°C, V_{DD}=50V, V_G=10V, R_G=25Ω.

Typical Electrical and Thermal Characteristic Curves

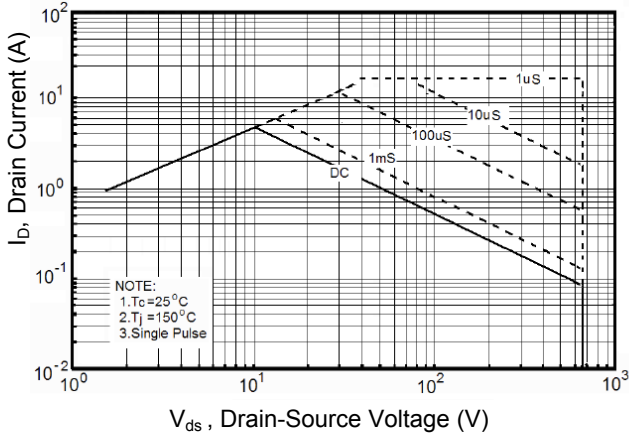


Figure 1. Safe Operating Area

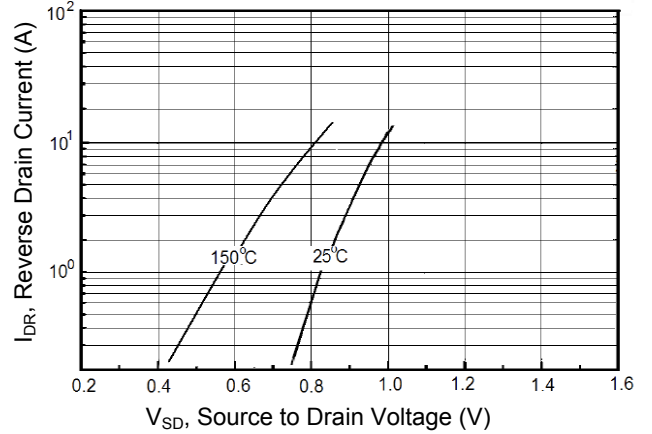


Figure 2. Source-Drain Diode Forward Voltage

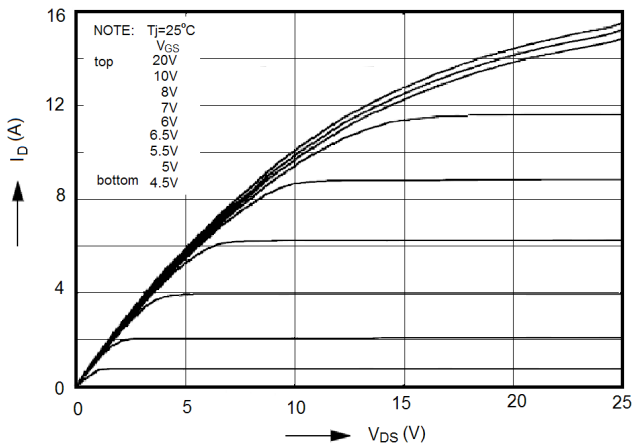


Figure 3. Output Characteristics

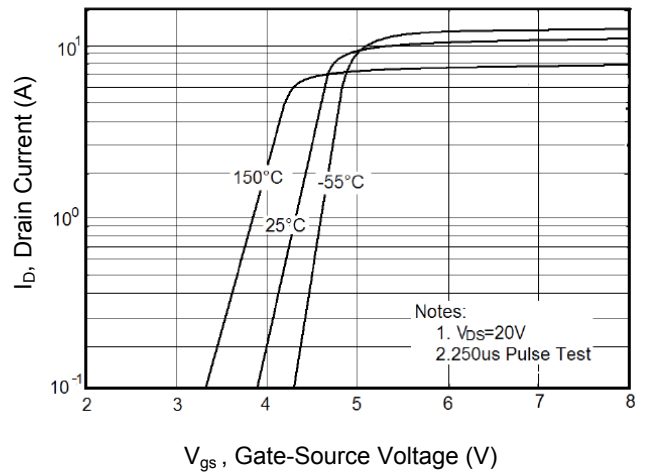


Figure 4. Transfer Characteristics

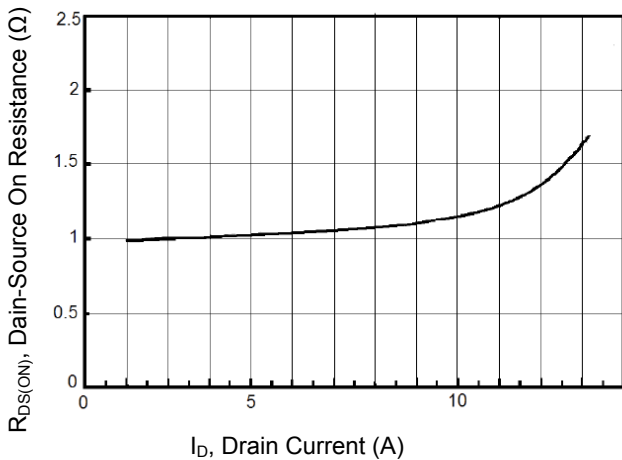


Figure 5. Static Drain-source on Resistance

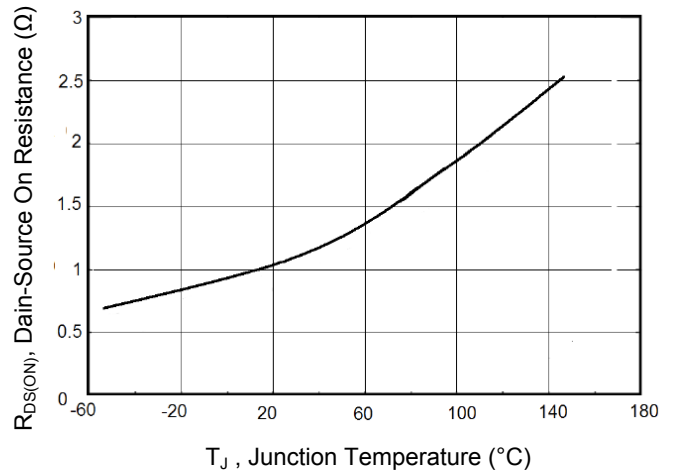


Figure 6. $R_{DS(ON)}$ vs Junction Temperature

Typical Electrical and Thermal Characteristic Curves

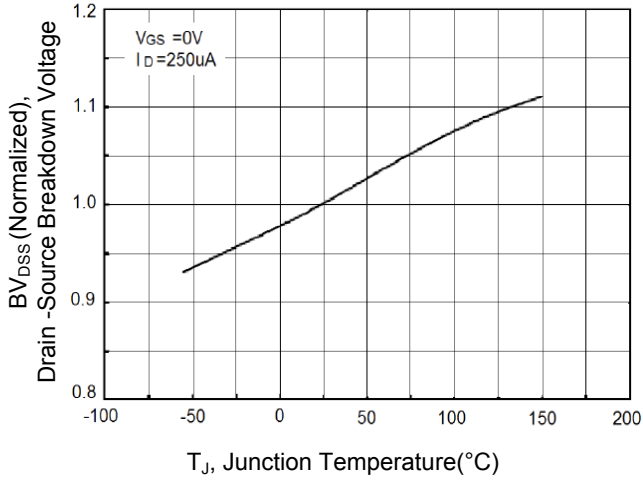


Figure 7. BV_{DSS} vs. Junction Temperature

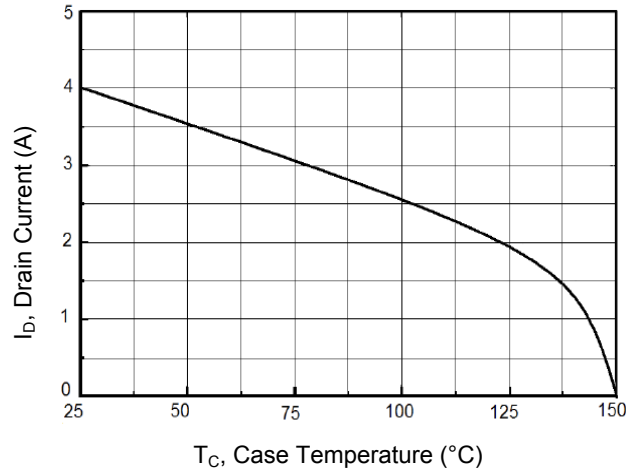


Figure 8. Maximum I_D vs Junction Temperature

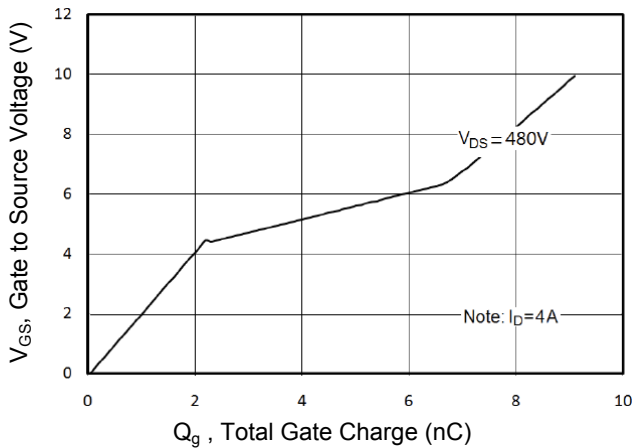


Figure 9. Gate Charge Waveforms

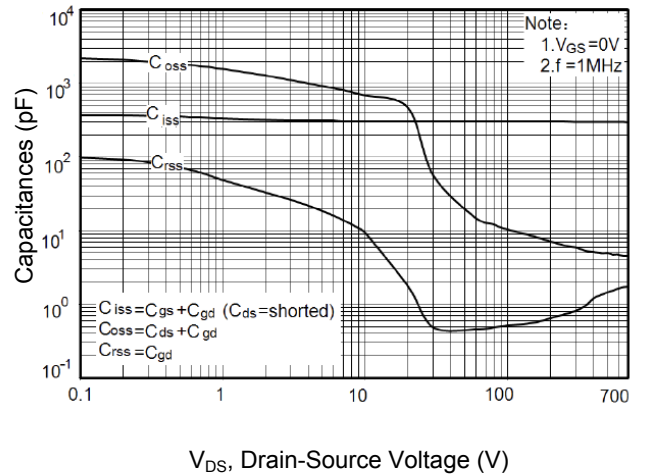


Figure 10. Capacitance

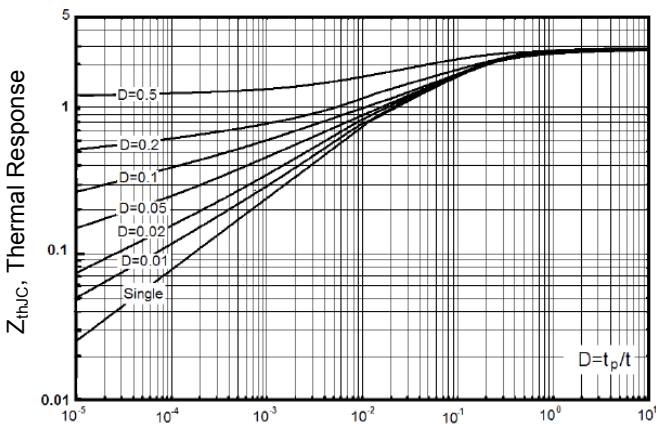


Figure 11. Transient Thermal Impedance

Typical Electrical and Thermal Characteristic Curves

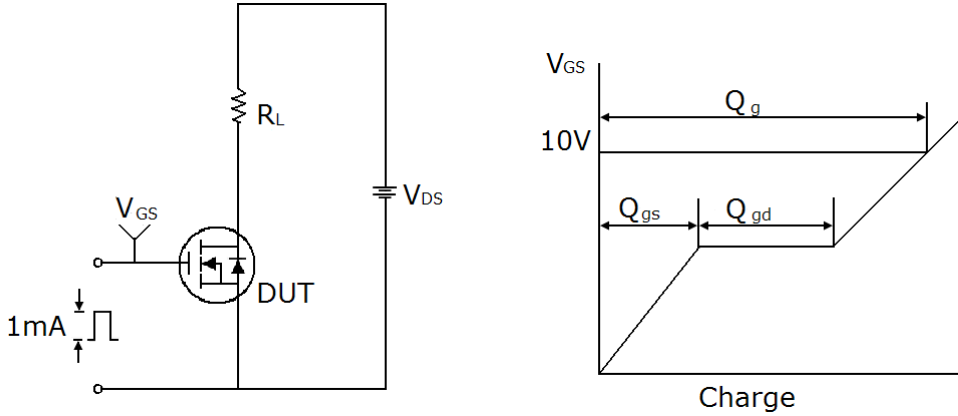


Figure 12. Gate Charge Test Circuit & Waveform

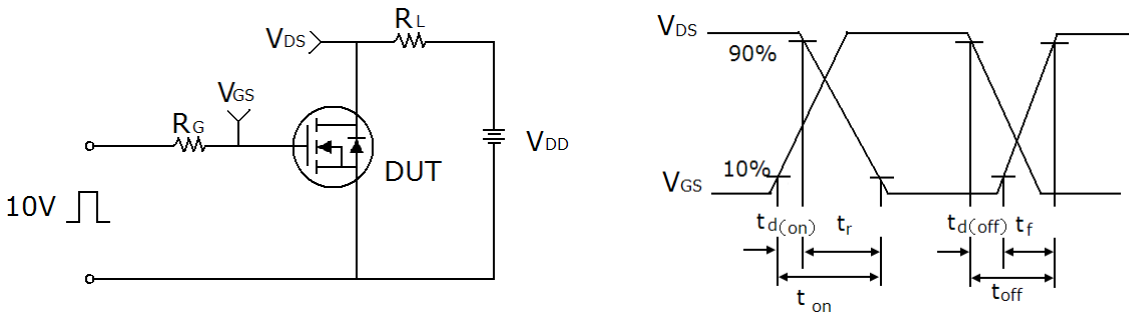


Figure 13. Switch Time Test Circuit:

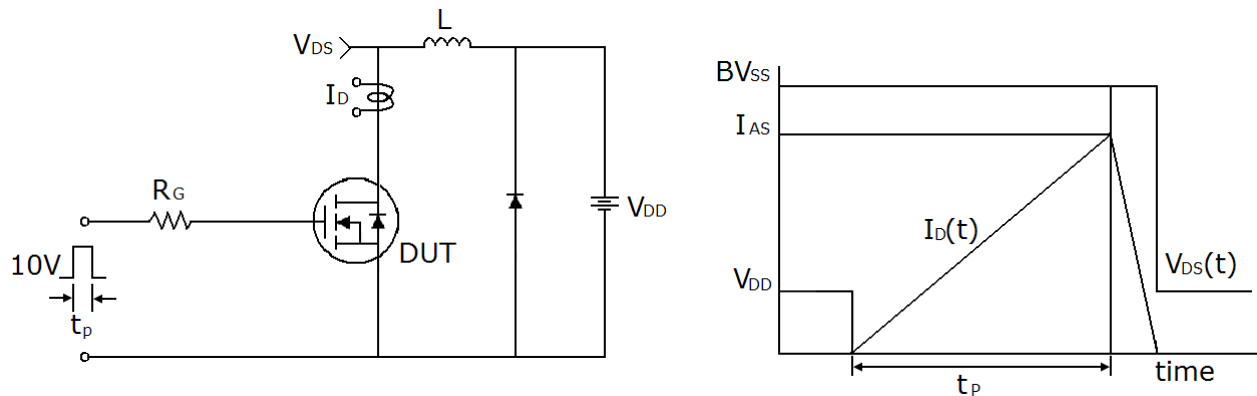
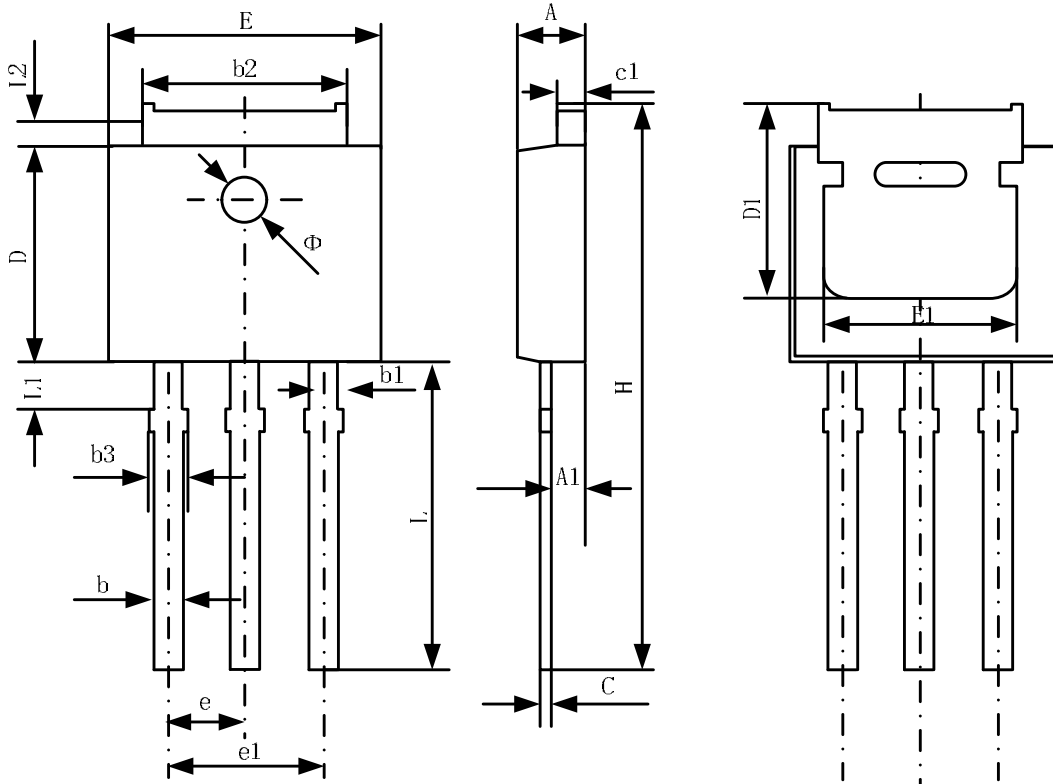


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

Package Outline Dimensions (TO-251)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.20	2.35	0.087	0.093
A1	0.90	1.10	0.035	0.043
b	0.56	0.69	0.022	0.027
b1	0.77	0.90	0.030	0.035
b2	5.23	5.43	0.206	0.214
b3	-	1.05	0.000	0.041
C	0.46	0.59	0.018	0.023
c1	0.46	0.59	0.018	0.023
D	6.00	6.20	0.236	0.244
D1	5.20	-	0.205	-
E	6.50	6.70	0.256	0.264
E1	4.60	5.00	0.181	-
e	2.24	2.34	0.088	0.092
e1	4.47	4.67	0.176	0.184
H	16.18	16.78	0.637	0.661
L	9.00	9.60	0.354	0.378
L1	0.95	1.35	0.037	0.053
L2	0.90	1.25	0.035	0.049